

# SPECIFICATION

DEVICE NAME : Power MOSFET

TYPE NAME : 2SK2753-01

SPEC. No. : \_\_\_\_\_

Fuji Electric Co.,Ltd.

This Specification is subject to change without notice.

	DATE	NAME	APPROVED		Fuji Electric Co.,Ltd.	
DRAWN						
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1. Scope  
This specifies Fuji power MOSFET 2SK2753-01
2. Construction N-channel enhancement mode power MOSFET
3. Application for switching
4. Outview T0-3P Outview See to 5/11 page

5. Absolute maximum ratings at  $T_c=25^\circ\text{C}$  (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain-source voltage	$V_{DS}$	120	V	
Drain-gate voltage	$V_{DGR}$	120	V	$R_{GS}=20\text{K}\Omega$
Continuous Drain current	$I_D$	$\pm 50$	A	
Pulsed drain current	$I_{Dpul}$	$\pm 200$	A	
Gate-source voltage	$V_{GS}$	$\pm 30$	V	
Maximum power dissipation	$P_D$	150	W	
Operating and storage temperature range	$T_{ch}$ $T_{stg}$	150 -55 ~ +150	$^\circ\text{C}$ $^\circ\text{C}$	

6. Electrical characteristics at  $T_c=25^\circ\text{C}$  (unless otherwise specified)  
Static ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Drain-source breakdown voltage	$B V_{DSS}$	$I_D = 1\text{mA}$ $V_{GS} = 0\text{V}$	120			V
Gate threshold voltage	$V_{GS(th)}$	$I_D = 10\text{mA}$ $V_{DS} = V_{GS}$	2.5	3.0	3.5	V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = 120\text{V}$ $V_{GS} = 0\text{V}$	$T_{ch} = 25^\circ\text{C}$	10	500	$\mu\text{A}$
	$I_{DSS}$		$T_{ch} \leq 125^\circ\text{C}$	0.2	1.0	$\text{mA}$
Gate-source leakage current	$I_{GSS}$	$V_{GS} = \pm 30\text{V}$ $V_{DS} = 0\text{V}$		10	100	$\text{nA}$
Drain-source on-state resistance	$R_{DS(on)}$	$I_D = 25\text{A}$ $V_{GS} = 10\text{V}$		24	32	$\text{m}\Omega$

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Dynamic ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Forward transconductance	$g_{fs}$	$I_D = 25A$ $V_{DS} = 25V$	25	50		S
Input capacitance	$C_{iss}$	$V_{DS} = 25V$ $V_{GS} = 0V$ $f = 1MHz$		4250	6400	pF
Output capacitance	$C_{oss}$			820	1200	pF
Reverse transfer capacitance	$C_{rss}$			250	370	pF
Turn-on time	$t_{d(on)}$	$V_{CC} = 50V$ $V_{GS} = 10V$ $I_D = 50A$ $R_{GS} = 10\Omega$		30	45	ns
	$t_r$			150	230	ns
Turn-off time	$t_{d(off)}$			160	240	ns
	$t_f$			140	210	ns

Reverse diode

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Avalanche capability	$I_{AV}$	$L = 100\mu H, T_{ch} = 25^\circ C$ *See Fig.1 and 2	50			A
Diode forward on-voltage	$V_{SD}$	$I_F = 2 \times I_{DR}$ $V_{GS} = 0V, T_{ch} = 25^\circ C$		1.3	2.0	V
Reverse recovery time	$t_{rr}$	$I_F = I_{DR}$ $V_{GS} = 0V$ $-di_F/dt = 100A/\mu s$ $T_{ch} = 25^\circ C$		150		ns
Reverse recovery charge	$Q_{rr}$				1.1	

7. Thermal resistance

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Thermal resistance	$R_{th_{ch-c}}$				0.833	$^\circ C/W$
	$R_{th_{ch-a}}$				35.0	$^\circ C/W$

Fig.1 Test circuit

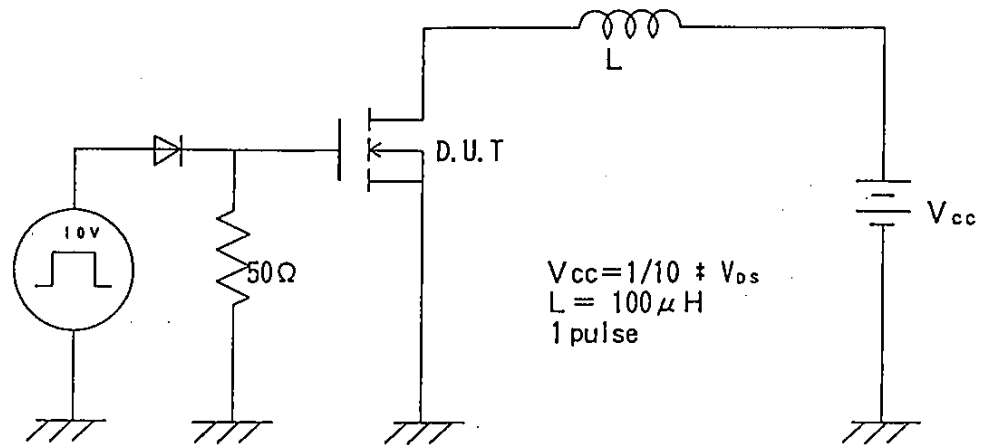
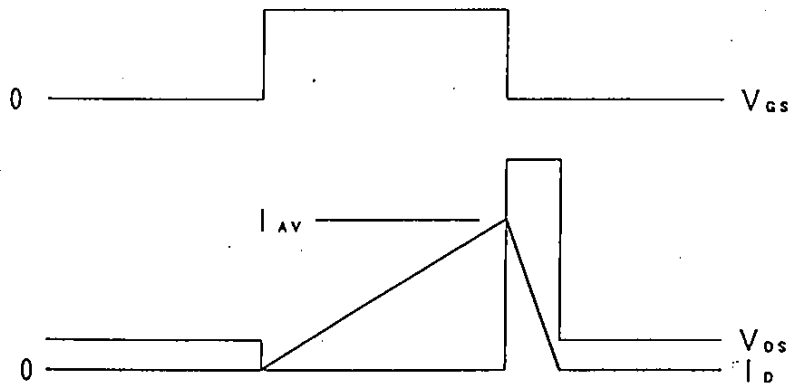
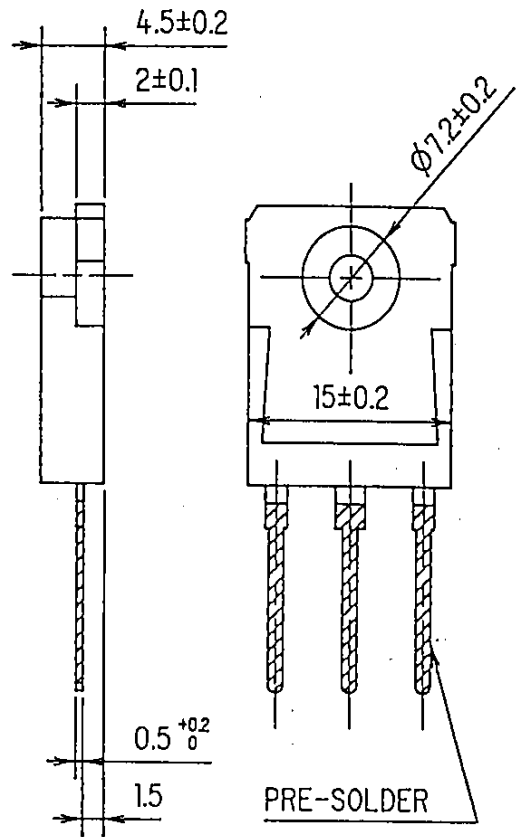
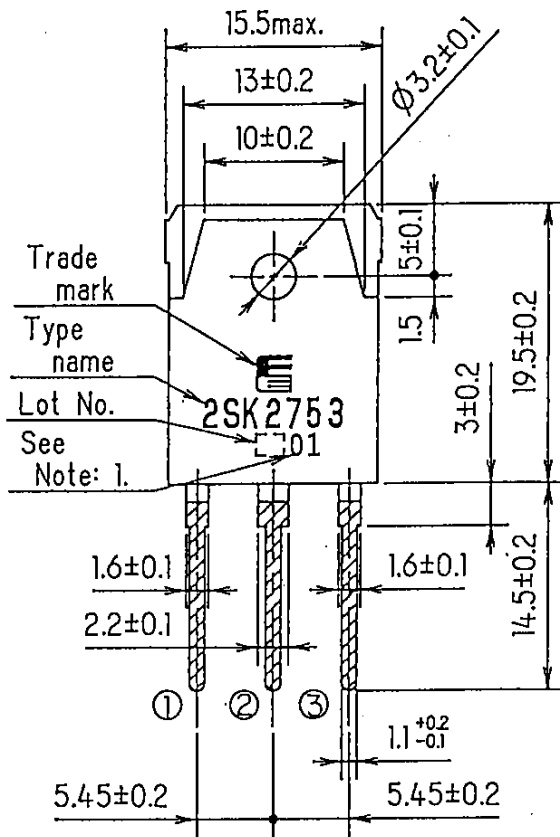


Fig.2 Operating waveforms

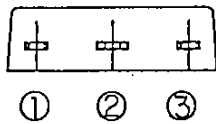


FUJI POWER MOS FET

TYPE : 2SK2753-01



DIMENSIONS ARE IN MILLIMETERS.



CONNECTION

- ① GATE
- ② DRAIN
- ③ SOURCE

Note: 1. Guaranteed mark of avalanche ruggedness.

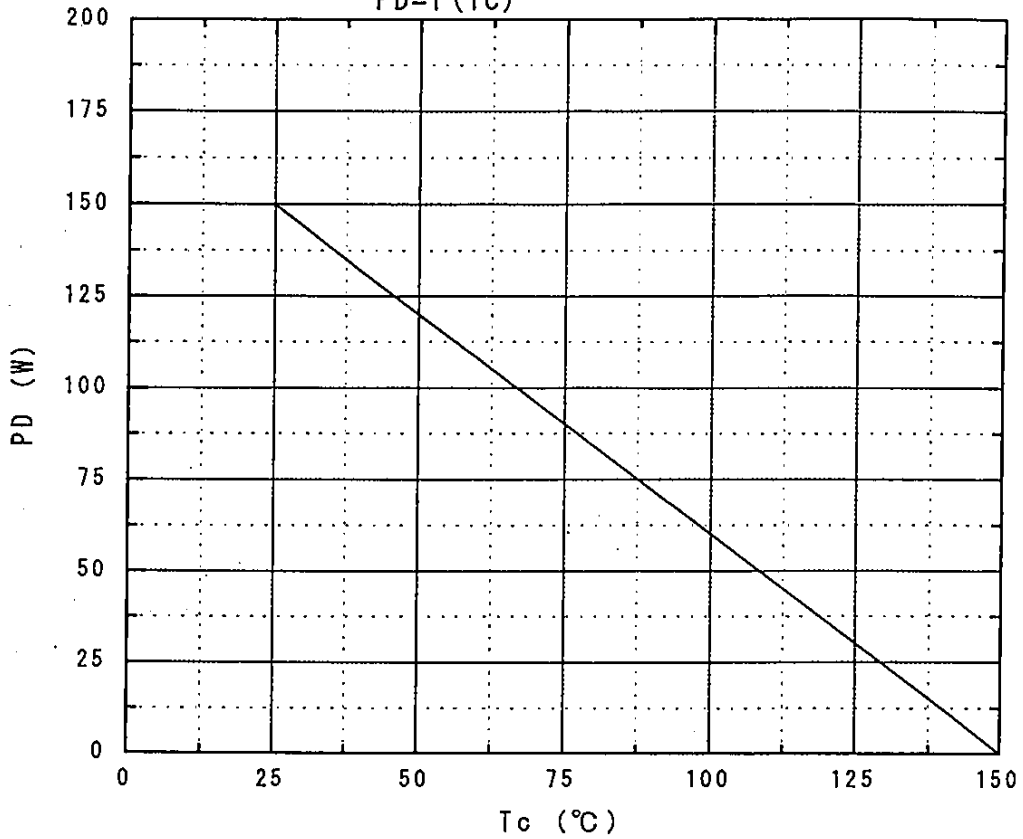
JEDEC : TO-247  
EIAJ : SC-65

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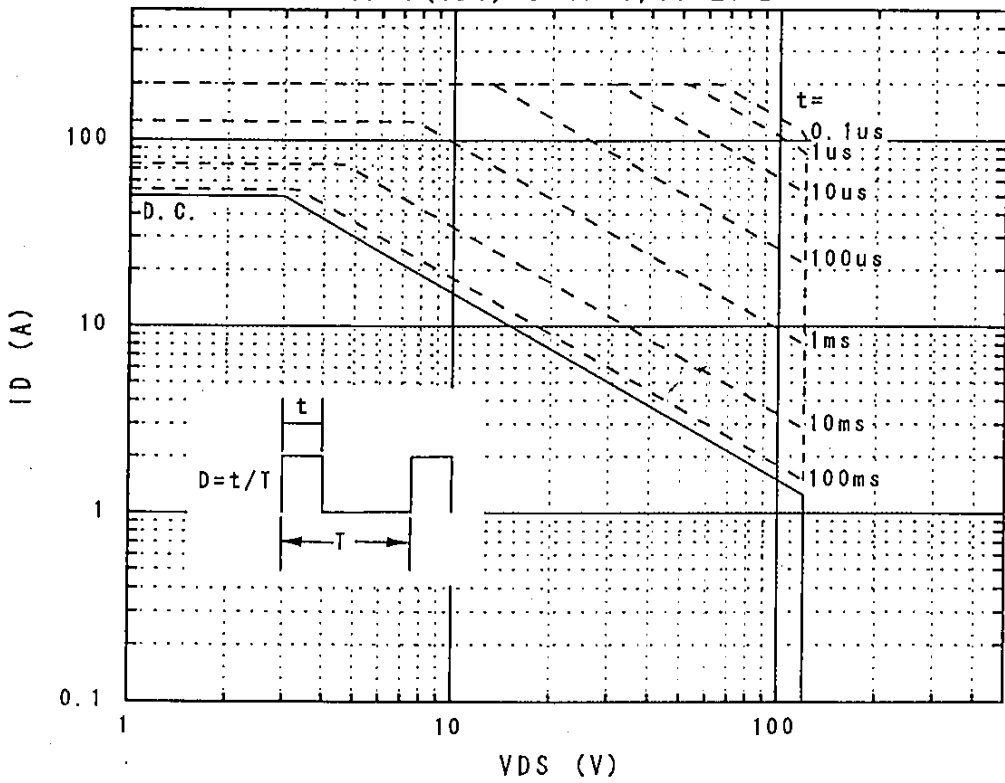
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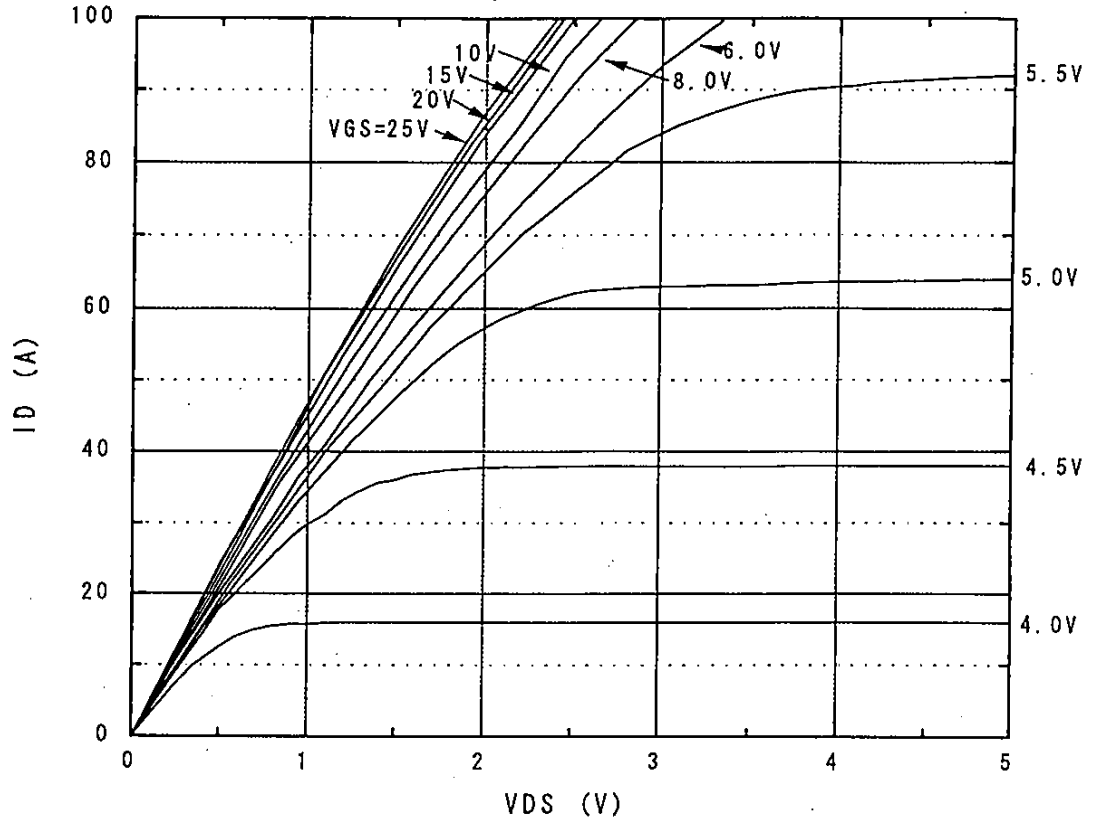
Power dissipation  
 $PD=f(T_c)$



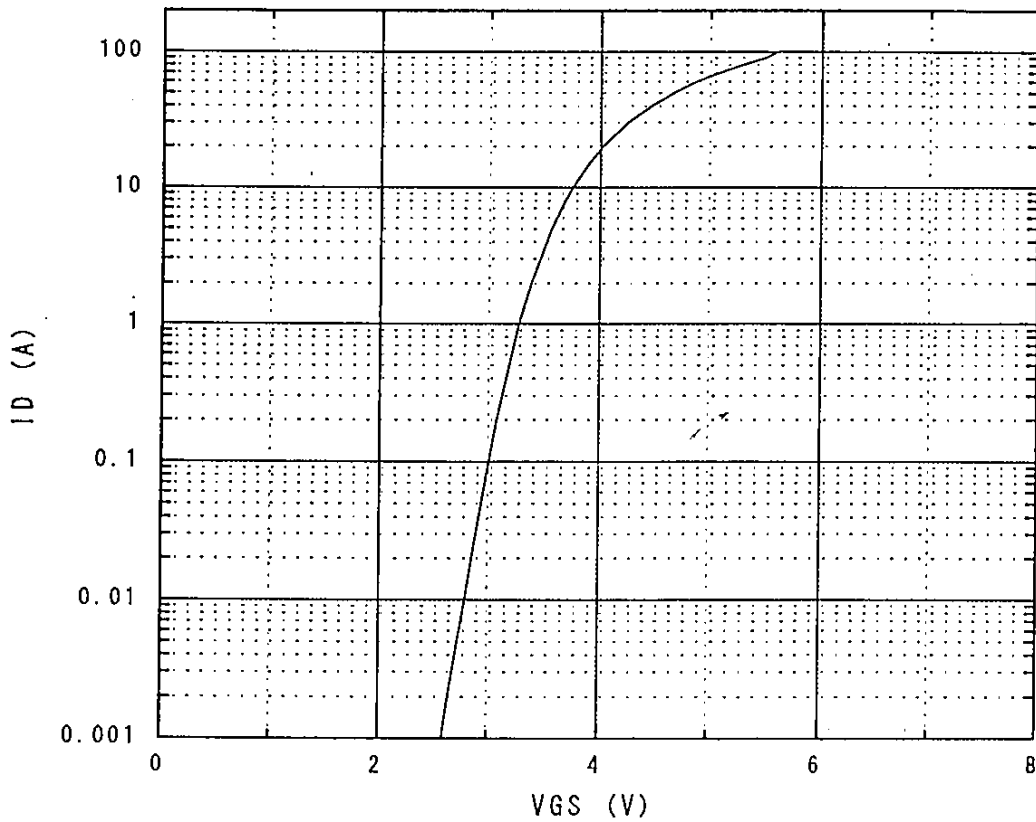
Safe operating area  
 $ID=f(V_{DS}) : D=0.01, T_c=25^\circ C$



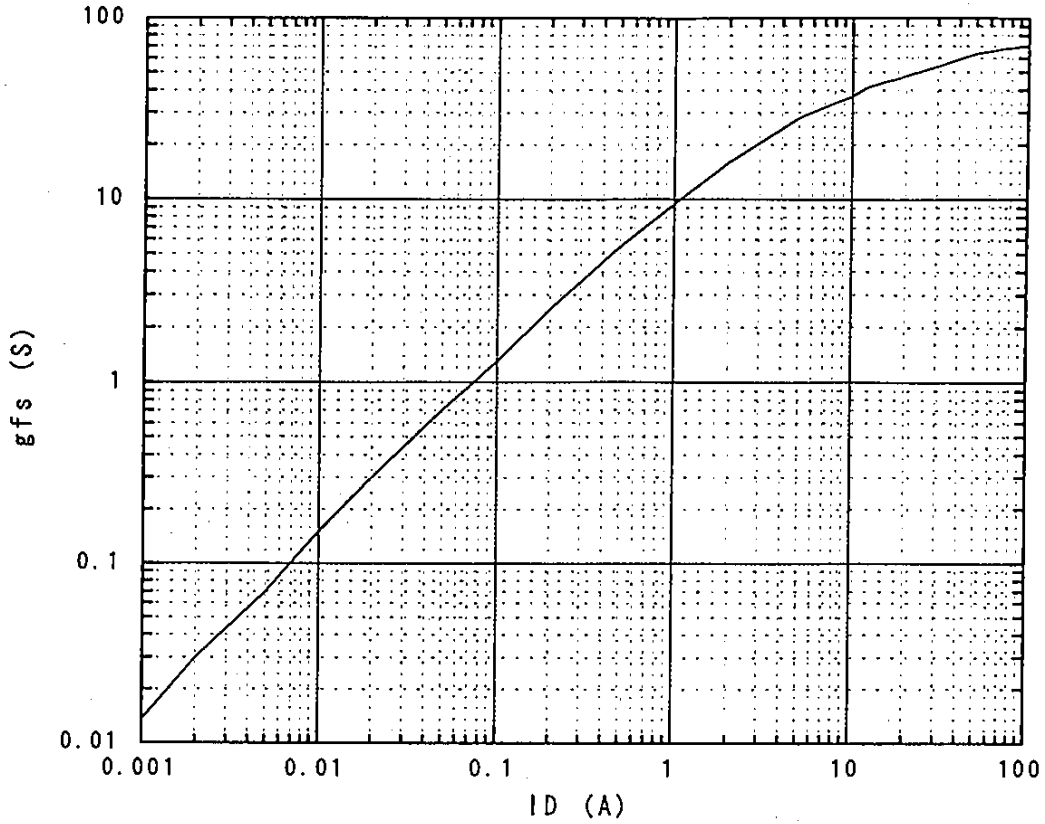
Typical output characteristics  
 $I_D = f(V_{DS})$ : 80us pulse test,  $T_{ch} = 25^\circ\text{C}$



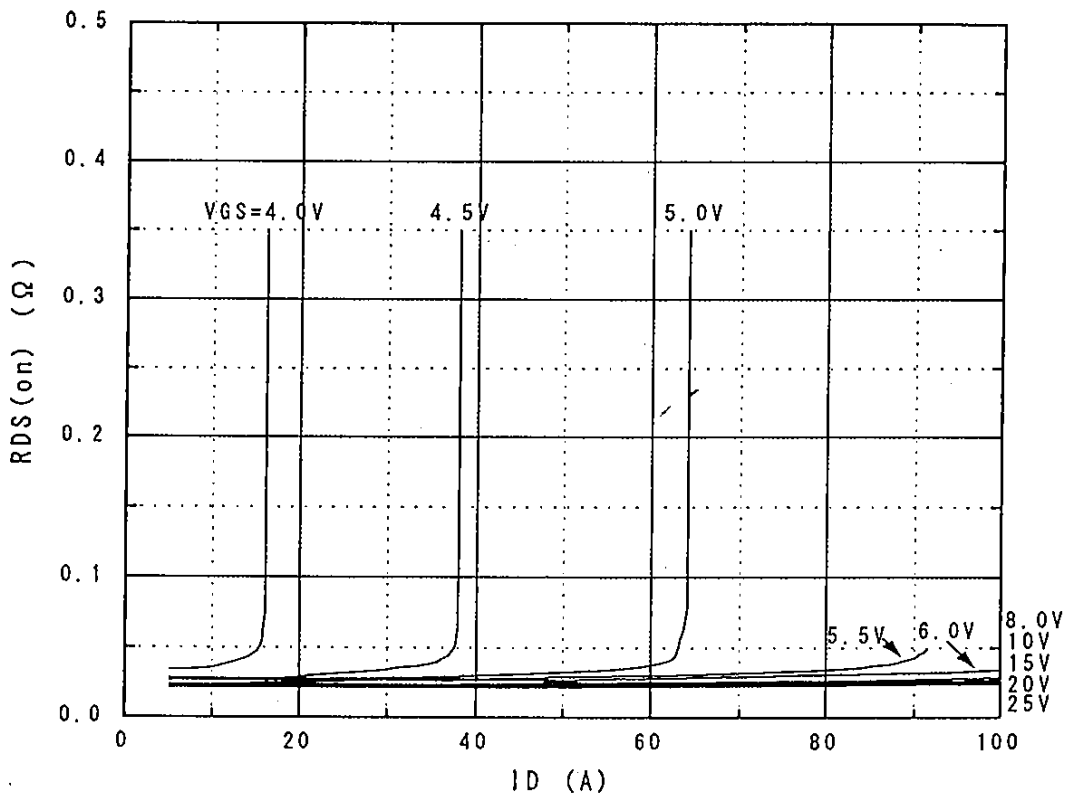
Typical transfer characteristic  
 $I_D = f(V_{GS})$ : 80us pulse test,  $V_{DS} = 25\text{V}$ ,  $T_{ch} = 25^\circ\text{C}$



Typical transconductance  
 $g_{fs}=f(I_D)$ : 80us pulse test,  $V_{DS}=25V$ ,  $T_{ch}=25^\circ C$

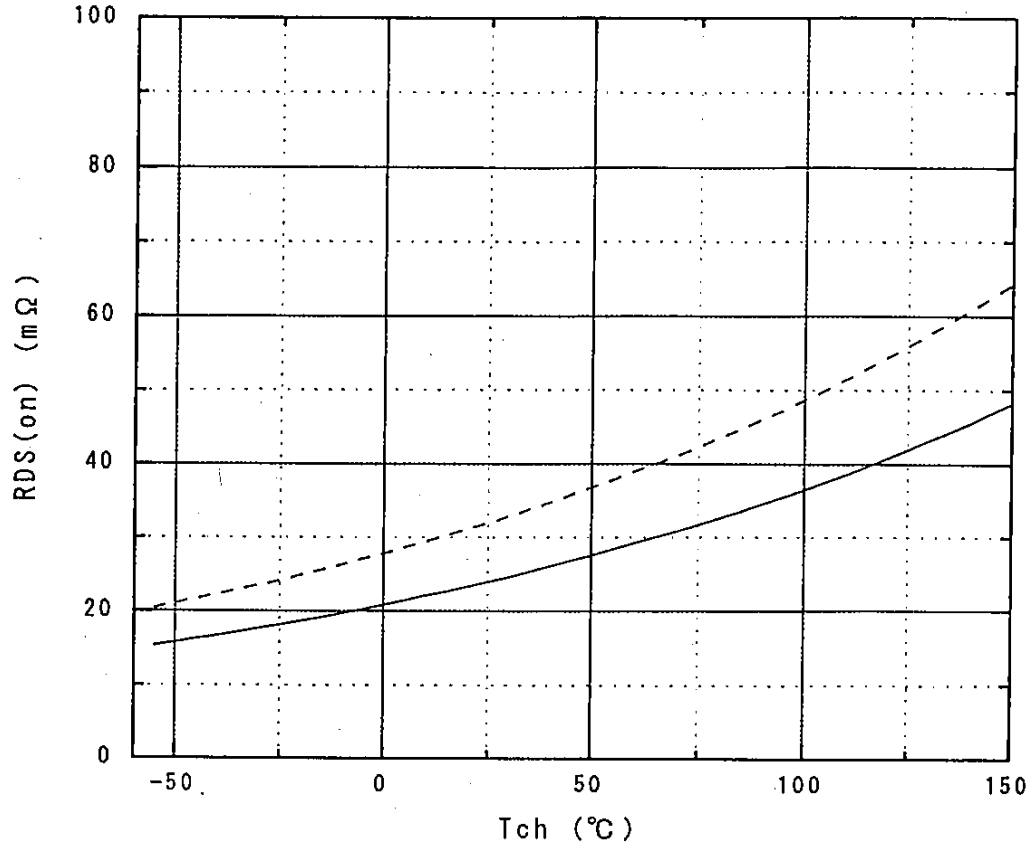


Typical drain-source on-state resistances  
 $R_{DS(on)}=f(I_D)$ : 80us pulse test,  $T_{ch}=25^\circ C$

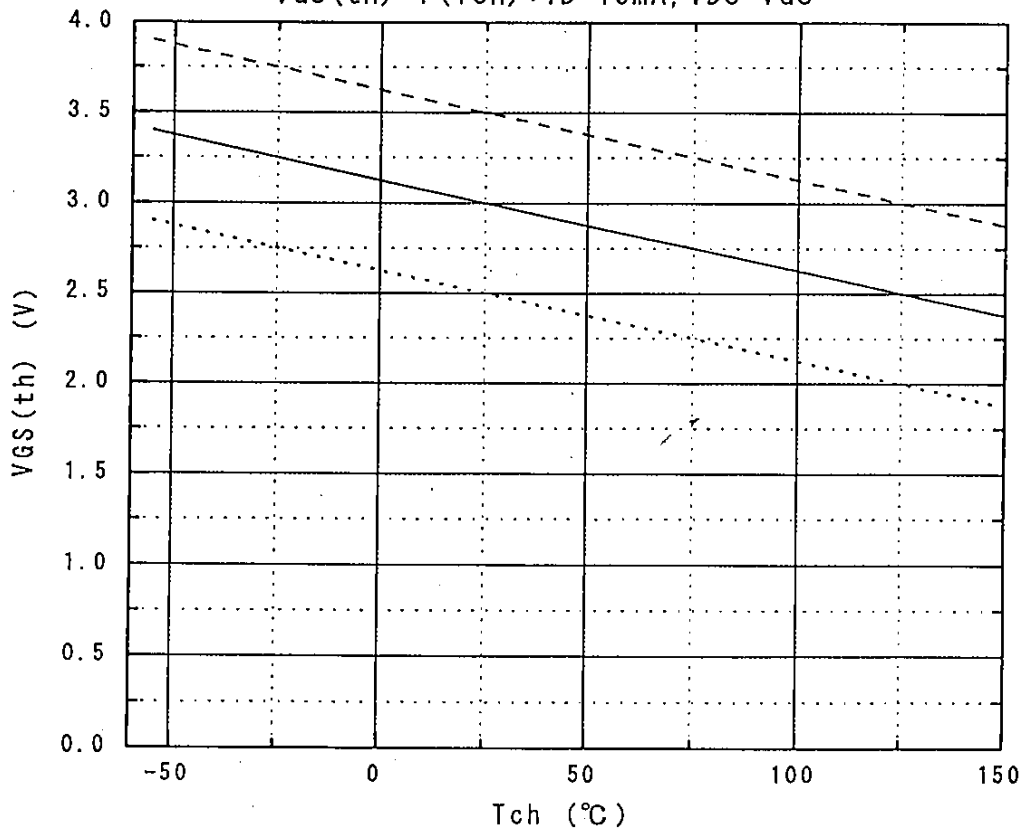




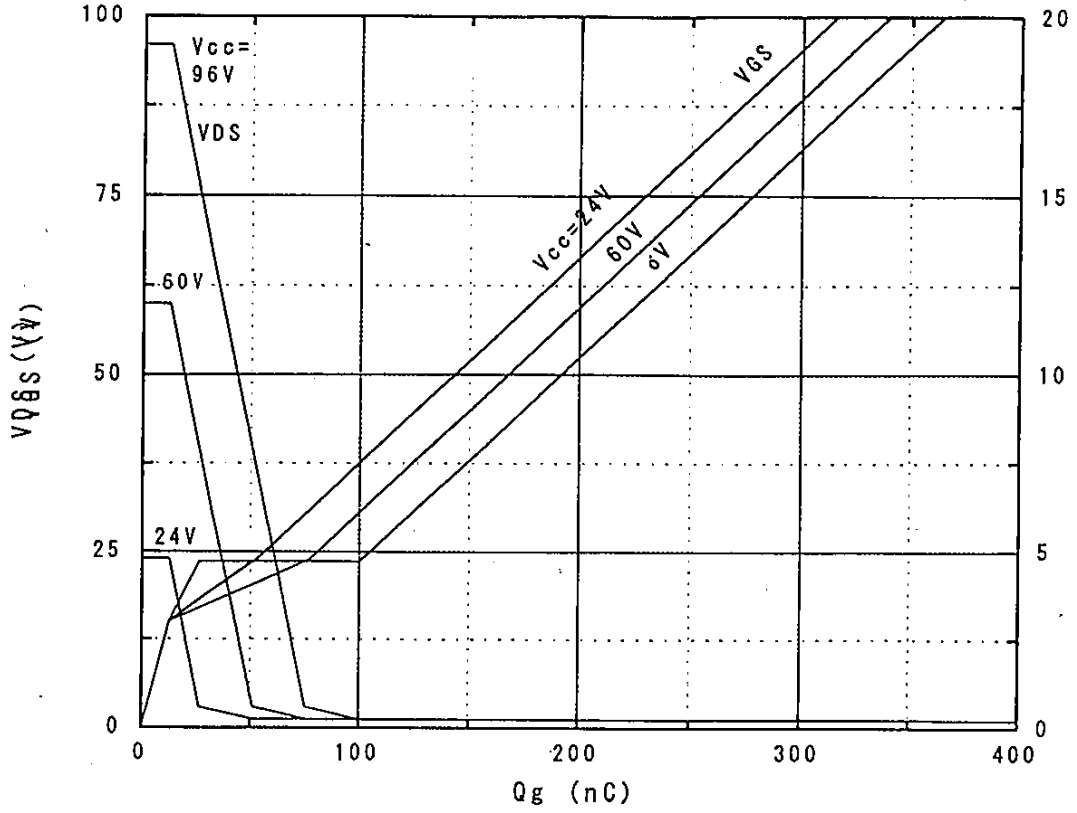
Drain-source on-state resistance  
 $R_{DS(on)} = f(T_{ch}) : I_D = 25A, V_{GS} = 10V$



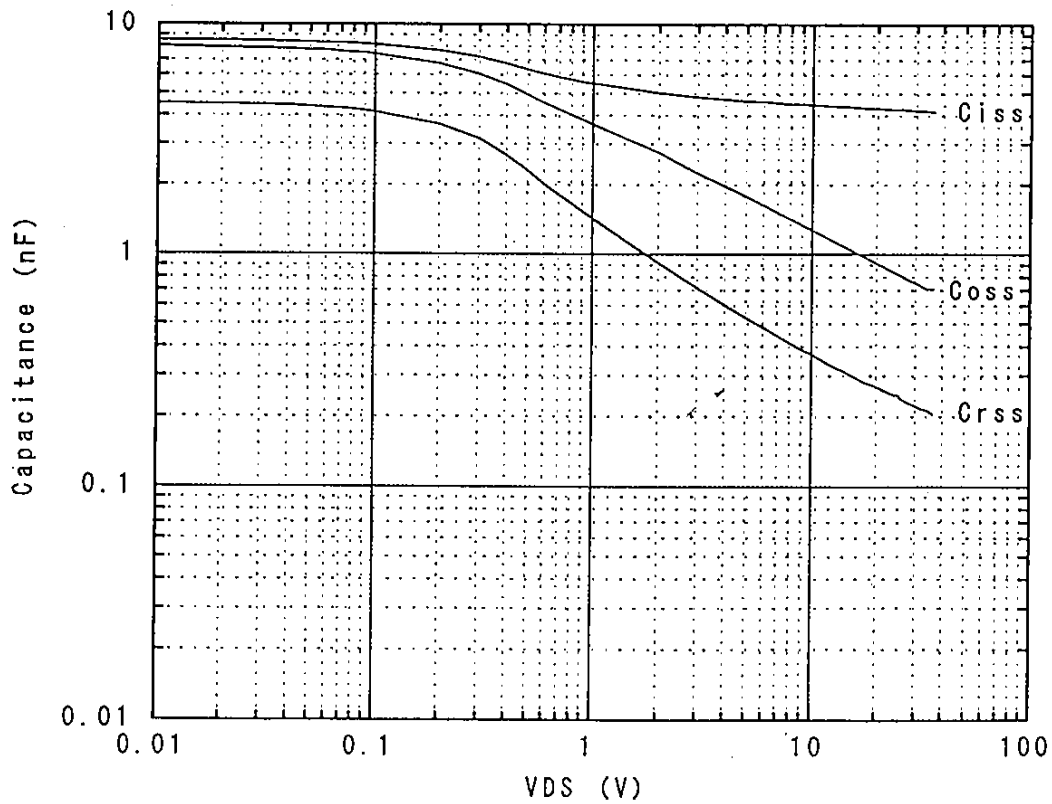
Gate threshold voltage  
 $V_{GS(th)} = f(T_{ch}) : I_D = 10mA, V_{DS} = V_{GS}$



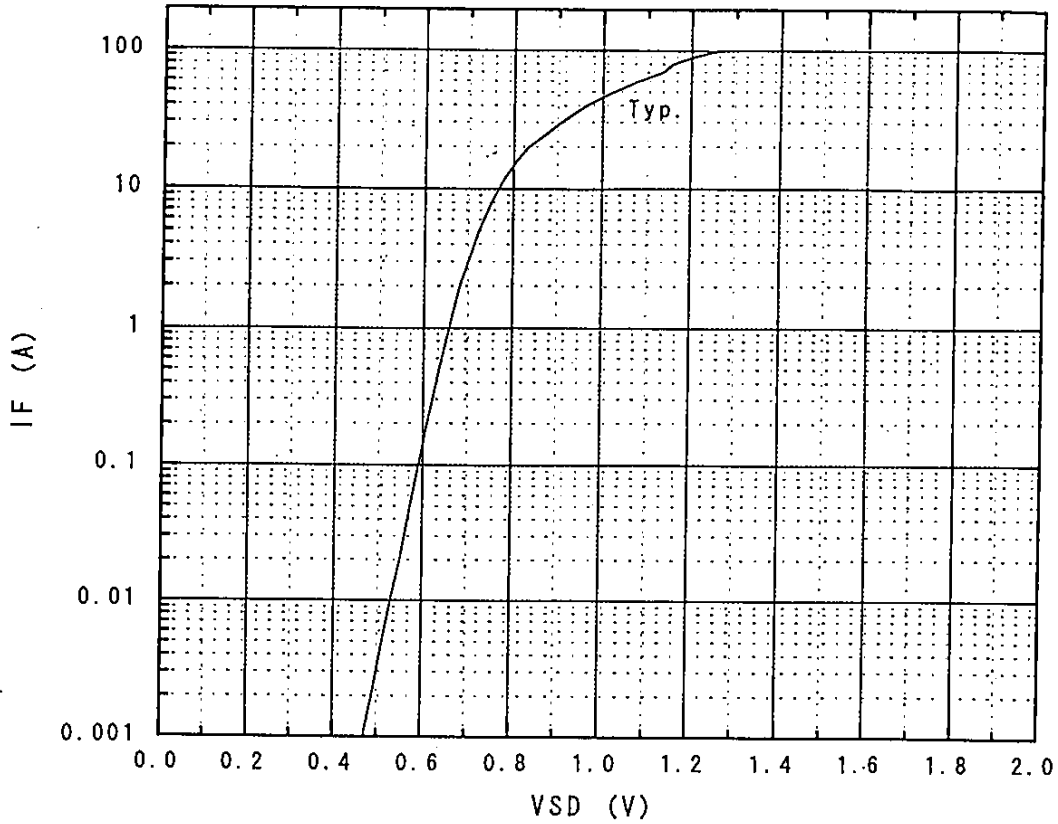
Typical gate charge  
 $V_{GS} = f(Q_g) : I_D = 50A$



Typical capacitances  
 $C = f(V_{DS}) : V_{GS} = 0V, f = 1MHz$



Forward characteristic of reverse diode  
 $I_F = f(V_{SD})$ : 80 $\mu$ s pulse test,  $V_{GS} = 0V$ ,  $T_{ch} = 25^\circ C$



Transient thermal impedance  
 $Z_{th}(ch-c) = f(t)$ : parameter  $D = t/T$

